Time-domain measurement of intersubband oscillations in a quantum well

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We report time-domain measurements of electron intersubband oscillations in quantum wells. We use an interferometric technique to measure the change in the profile of a few-cycle THz pulse due to propagation through a modulation-doped Al0.3Ga0.7As/GaAs multiple quantum well structure (10×510 Å wells). From this data we obtain the absorption and the index of refraction due to electrons in the quantum well, and due to the GaAs substrate. Unlike existing studies of coherent charge oscillations of electrons and holes in heterostructures excited by ultrashort pulses of band-gap light, our all-THz measurements quantitatively determine the linear optical properties of the quantum well electrons.

In time-domain spectroscopy the time evolution of a system is measured following impulsive excitation. The ability to generate ultrashort pulses of terahertz (THz) radiation has made time-domain spectroscopy possible at THz frequencies (THz-TDS). THz-TDS has emerged as an important technique for studying carrier dynamics in quantum wells (QWs), in which carriers scatter and dephase on picosecond time scales. We are interested in understanding carrier scattering and dephasing in quantum wells because these processes are important for the design THz sources and detectors based on intersubband transitions.

Several authors have investigated coherent charge oscillations in quantum wells following pulsed interband excitation. Roskos et al. used ultrashort laser pulses to excite a coupled double quantum well, producing excitons in a coherent superposition of states. They observed THz emission due to the resulting coherent tunneling of electrons between the two wells. Planken et al. observed THz emission from a single quantum well by coherent excitation of holes into the light and heavy hole subbands. THz emission due to transient Bloch oscillations in a superlattice was reported by Waschke et al. Bonvalet et al. have used the THz emission to determine both the dephasing rate and the lifetime of excitons in a single quantum well. Sequences of ultrashort laser pulses have also been used to coherently control exciton populations. Brener et al. have studied coherent terahertz radiation from quantum wells when the exciting optical fields were shaped both in amplitude and phase. Heberle et al. used a sequence of phase-locked femtosecond pulses to create and destroy a charge oscillation in a quantum well, demonstrating that optical nonlinearities can be switched on and off in a time shorter than the phase relaxation time.

Few-cycle THz radiation can be used to perform linear optical spectroscopy in the time domain. This technique can be applied to free carriers and carriers in quantum wells. Some and Nurmikko have used few-cycle THz radiation to detect coherent cyclotron resonance oscillations by free electrons in modulation-doped heterostructures. In this letter, we present the first linear spectra of intersubband transitions of electrons in quantum wells measured by THz-time domain spectroscopy. Unlike frequency domain or Fourier transform spectroscopy, THz-TDS can be combined with pulsed excitation to perform time-resolved spectroscopy on picosecond time scales. Additionally, the technique we present here allows simultaneous measurement of both absorption and dispersion.

In our time-resolved experiments, 80 fs pulses from a Tsunami Ti-sapphire laser are divided at a beamsplitter into sample and analysis beams (see inset, Fig. 1). The sample beam is used to generate few-cycle THz pulses by exciting coherent plasma oscillations in n = 10^17 cm^-3 doped bulk GaAs. The energy in each THz pulse is of the order 10^-16 J.

FIG. 1. Cross-correlation signal (dots) measured with no sample (above) and with the 6.06 mm long edge-coupled quantum well sample (T=6 K) (below). The solid lines are guides to the eye. In this measurement the quantum wells are depleted of charge. The change in the cross-correlation signal is due to the frequency-dependent index of refraction of the semi-insulating GaAs substrate. The time offset between the signals is Δ = 52.2 ps. (Inset) Schematic diagram of experimental apparatus. An 80 fs λ = 800 nm Ti-sapphire laser (1) produces few-cycle THz pulses at the emitters (2). THz pulses are transmitted through the sample (3) and mixed with reference THz pulses at a beamsplitter. We detect the superposition of the pulses as a function of the delay between them with a bolometer (4).

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(~10^5 photons). This THz radiation is transmitted through the sample. The analysis beam is sent through a variable delay stage, and is then used to generate approximately single-half-cycle THz pulses at a low temperature (LT) GaAs epitaxial layer on semi-insulating (SI)-GaAs. Time resolution is obtained by mixing the sample and analysis THz pulses at a Ge beamsplitter and detecting the superposition with an integrating detector (4.2 K Si bolometer) as a function of the delay between pulses. To enhance the signal-to-noise ratio in these cross-correlation measurements, the sample and analysis beams are modulated at separate frequencies and the signal is detected in double modulation using two lock-in amplifiers.

The design of our modulation-doped multiple quantum well structure consists of ten periods of symmetrically modulated 510 Å GaAs wells separated by 1600 Å Al0.3Ga0.7As buffers, grown on a SI GaAs substrate. The sample has an aluminum Schottky gate on the surface and AuGe alloyed ohmic contacts on the quantum wells. The sample is treated as a uniform effective medium and the intersubband transition. The reference signal measured while modulating the QW carrier density between n_s = 2.75 \times 10^{10} \text{ cm}^{-2} and depleted. The signal contains only a narrow band of frequency components, and so is not distorted much by the chirp. It arises because the incident THz pulse excites carriers into a coherent superposition of states in the first and second subbands (see sketch in inset). The solid line is a simulation calculated from a single-oscillator model of the quantum well response and the reference cross-correlation signal.

FIG. 2. Measured cross-correlation signal (dots) obtained by modulating the charge density in the 510 Å quantum well sample, and recording the change in transmission with a lock-in amplifier. The THz pulse excites electrons into a coherent superposition of states in the lowest two subbands (see sketch in inset). The solid line is a simulation calculated from a single-oscillator model of the quantum well response and the reference cross-correlation signal.

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\[
S(t_0) = \int_{-\infty}^{\infty} \left[ E_S(t) + E_A(t + t_0) \right]^2 dt, \tag{1}
\]

where \(E_S(t)\) and \(E_A(t)\) describe the electric field at the detector from the sample-beam and analysis-beam pulses, and \(t_0\) is the delay between the pulses. The term which varies with delay is the cross-correlation signal

\[
X(t_0) = \int_{-\infty}^{\infty} E_S(t) E_A(t + t_0) dt. \tag{2}
\]

The (complex) frequency spectrum is the Fourier transform of the time-domain function

\[
E_S(t) = \frac{1}{2\pi} \int_{-\infty}^{\infty} E_S(\omega) e^{i\omega t} d\omega \tag{3}
\]

In the following, we describe the optical properties of the sample in terms of a complex transfer function \(T(\omega)\) where \(E_S(\omega) = T(\omega)E_0(\omega)\), and \(E_0(\omega)\) is the frequency spectrum of the sample beam when the sample is removed. The sample transfer function is found to be the ratio of the cross-correlation signal and a reference signal recorded with the sample removed \(X_0(t)\)

\[
T(\omega) = \int_{-\infty}^{\infty} X(t_0) e^{i\omega t_0} dt_0 / \int_{-\infty}^{\infty} X_0(t_0) e^{i\omega t_0} dt_0. \tag{4}
\]

In Fig. 3 we display the amplitude and phase of the complex transfer function associated with the intersubband transition. The reference signal \(X_0(t)\) is measured with the QW depleted. The sample signal \(X_S(t)\) is the sum of the signal measured while modulating the carrier density (Fig. 2) and \(X_0(t)\). As seen in Fig. 3, we can get an excellent fit to the data using a transfer function derived from a single-oscillator model of the electric susceptibility of the QW electrons. In the model, the sample is treated as a uniform effective medium and the intersubband frequency, oscillator strength, and dephasing rate of the electrons are adjusted to best fit the data. The best fit yields an intersubband frequency \(\nu_{12} = 1.51\ \text{THz (50.3 cm}^{-1})\), an electron oscillator strength of \(f = 0.6\), and a lifetime for dephasing of the electric field...
amplitude $\tau=2.4$ ps. Finally, we can use this model transfer function together with the reference signal to simulate a cross-correlation signal (Fig. 2) which can be directly compared to our experimental data.

We simulated our structure by self-consistently solving the Schrödinger and Poisson equations within the effective mass approximation. The calculated intersubband absorption frequency (including the depolarization shift) fits the experimental data when the well width is set to 510 Å, which agrees with the design width (540 Å) within the margin of error. The calculated subband spacing is then $E_{12} = 5.1$ meV (41.1 cm$^{-1}$). Since the Fermi energy is only 1 meV, only the lowest subband in the quantum well is appreciably occupied at $T = 6$ K ($n_2/n_1 \sim 10^{-4}$). We are confident that we observe only the $n=1$ to $n=2$ transition because other transitions from $n=1$ are much weaker and occur at higher frequencies. The calculated electron oscillator strength for the $n=1$ to $n=2$ transition is $f_{1,2}=0.93$, larger than the experimental value $f_{1,2}=0.6$. Similar "anomalously weak" absorption in wide quantum wells has been observed by others, and has been tentatively attributed to the breakdown of the approximation of the sample as a uniform effective medium.

Our data also allow us to measure the index of refraction of the depleted sample from the phase $\phi_T$ of the transfer function using $n(\omega) = \phi_T c/(\omega x) + 1$, where $x$ is the length of the sample (6.06±0.01 mm). We have plotted in Fig. 4 the data together with the index of refraction calculated using

$$\epsilon(\omega) = \epsilon(\infty) \left( \frac{\omega^2 - \omega_0^2}{\omega_T^2 - \omega^2} \right).$$

The index of refraction determined by our THz-TDS measurement is in excellent agreement with the calculation, which has no free parameters. This is an important check of the accuracy of our technique.

In conclusion, we have made time-domain measurements of intersubband charge oscillations in a quantum well. Our all-THz measurements quantitatively determine the linear optical constants of the sample. Our results can be understood in terms of a single oscillator model of the intersubband transition. Our measurements also give the index of refraction of the sample as a function of frequency, in excellent agreement with well known results. We have additionally studied intersubband transitions in parabolic and coupled quantum wells with THz-TDS, and we intend to report these results elsewhere.

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10. We have obtained essentially identical results (but with higher noise) by analyzing the cross-correlation signals measured at 0 V bias and at −10 V bias.
13. The calculation used $\epsilon(\infty) = 10.9$, after C. J. Johnson, G. H. Sherman, and R. Weil, Appl. Opt. 8, 1667 (1969); and $\nu_{LO} = 296.4$ cm$^{-1}$ and $\nu_{TO} = 273.1$ cm$^{-1}$ after A. Mooradian and G. B. Wright, Solid State Commun. 4, 431 (1966).